54ACT16623, 74ACT16623 **16-BIT BUS TRANSCEIVERS** WITH 3-STATE OUTPUTS SCAS152A - JANUARY 1991 - REVISED APRIL 1996

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<ul> <li>Members of the Texas Instruments Widebus<sup>™</sup> Family</li> </ul>	75ACT16	54ACT16623 WD PACKAGE 75ACT16623 DL PACKAGE (TOP VIEW)				
<ul> <li>Inputs are TTL-Voltage Compatible</li> </ul>						
<ul> <li>Flow-Through Architecture Optimizes PCB Layout</li> </ul>	10EAB [ 1B1 [		48 ] 10EBA 47 ] 1A1			
<ul> <li>Distributed V<sub>CC</sub> and GND Pin Configuration Minimizes High-Speed Switching Noise</li> </ul>	1B2 [ GND [	3	46 ] 1A2 45 ] GND			
<ul> <li>EPIC<sup>™</sup> (Enhanced-Performance Implanted CMOS) 1-µm Process</li> </ul>	1B3 [ 1B4 [	5	44 ] 1A3 43 ] 1A4			
<ul> <li>Package Options Include Plastic 300-mil Shrink Small-Outline (DL) Packages Using</li> <li>Small Contex to Contex Din Specifier and</li> </ul>	V <sub>CC</sub> [ 1B5 [ 1B6 [	8	42 V <sub>CC</sub> 41 1A5 40 1A6			
25-mil Center-to-Center Pin Spacings and 380-mil Fine-Pitch Ceramic Flat (WD) Packages Using 25-mil Center-to-Center	GND [ 1B7 [	10	39 GND 38 1A7			
Pin Spacings	1B8 [	12	37 🛛 1A8			
	2B1 🛛	13	36 2A1			
description	2B2	14	35 2A2			
The 'ACT16623 are 16-bit transceivers designed	GND [ 2B3 [		34 GND 33 2A3			
for asynchronous two-way communication between data buses. The control-function implementation	2B4 [	17	32 <b>]</b> 2A4			
allows for maximum flexibility in timing.	00 =	18	31 V <sub>CC</sub>			
These devices can be used as two 8-bit	2B5		30 2A5			
transceivers or one 16-bit transceiver. They allow	2B6		29 2A6			
data transmission from the A bus to the B bus or	GND [ 2B7 [		28 GND 27 247			
from the B bus to the A bus, depending on the logic	2B7 [ 2B8 [		27   2A7 26   2A8			
$\frac{1}{1000}$ and $\frac{1}{1000}$		20	2°H 2A0			

The dual-enable configuration gives the bus transceiver the capability to store data by simultaneously enabling OEBA and OEAB. Each output reinforces its input in this transceiver configuration. When both control inputs are enabled and all other data sources to the two sets of bus lines are at high impedance, the bus lines remain at their last states.

The 74ACT16623 is packaged in TI's shrink small-outline package, which provides twice the functionality of standard small-outline packages in the same printed-circuit-board area.

The 54ACT16623 is characterized for operation over the full military temperature range of -55°C to 125°C. The 74ACT16623 is characterized for operation from -40°C to 85°C.



isolated.

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level at the output-enable (OEBA and OEAB)

inputs. The output-enable inputs can be used to disable the device so that the buses are effectively

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25 20EBA

24

20EAB

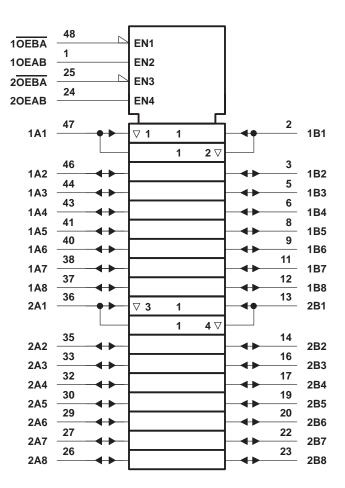
# 54ACT16623, 74ACT16623 **16-BIT BUS TRANSCEIVERS** WITH 3-STATE OUTPUTS

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#### **FUNCTION TABLE** (each 8-bit section)

INP	UTS								
OEBA	OEAB	OPERATION							
L	L	B data to A bus							
н	Н	A data to B bus							
н	L	Isolation							
L	Н	B data to A bus, A data to B bus							

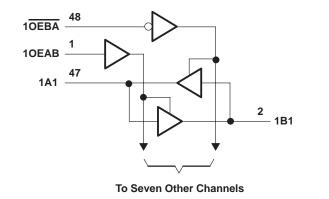
## logic symbol<sup>†</sup>

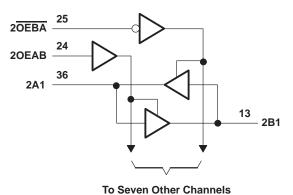


<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



## logic diagram (positive logic)





### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub>	–0.5 V to 7 V
Input voltage range, VI (see Note 1)	–0.5 V to V <sub>CC</sub> + 0.5 V
Output voltage range, V <sub>O</sub> (see Note 1)	-0.5 V to V <sub>CC</sub> + 0.5 V
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0 or V <sub>I</sub> > V <sub>CC</sub> )	±20 mA
Output clamp current, $I_{OK}$ ( $V_O < 0$ or $V_O > V_{CC}$ )	±50 mA
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V <sub>CC</sub> or GND	±400 mA
Maximum power package dissipation at $T_A = 55^{\circ}C$ (in still air) (see Note 2): DL packa	ge 1.2 W
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.

## recommended operating conditions (see Note 3)

		54ACT16623		74ACT16623			UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage (see Note 4)	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2		εh	2			V
VIL	Low-level input voltage		EL	0.8			0.8	V
VI	Input voltage	0	à	VCC	0		VCC	V
Vo	Output voltage	0	5	VCC	0		VCC	V
ЮН	High-level output current	40	2	-24			-24	mA
IOL	Low-level output current	20	/	24			24	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	0		10	0		10	ns/V
ТА	Operating free-air temperature	-55		125	-40		85	°C

NOTES: 3. Unused inputs should be connected to V<sub>CC</sub> through a pullup resistor of approximately 5 k $\Omega$  or greater.

4. All V<sub>CC</sub> and GND pins must be connected to the proper power supply.



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#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	N	T <sub>A</sub> = 25°C			54ACT16623		74ACT16623		UNIT	
		TEST CONDITIONS	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
			4.5 V	4.4			4.4		4.4			
		I <sub>OH</sub> = -50 μA	5.5 V	5.4			5.4		5.4			
VOH		I <sub>OH</sub> = -24 mA	4.5 V	3.94			3.8		3.8		V	
		IOH = -24 mA	5.5 V	4.94			4.8		4.8			
		$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V				3.85	2	3.85			
		l <sub>OL</sub> = 50 μA	4.5 V			0.1		0.1		0.1	V	
		ΙΟΓ = 30 μΑ	5.5 V			0.1		0.1		0.1		
VOL		I <sub>OL</sub> = 24 mA	4.5 V			0.36	~	0.44		0.44		
			5.5 V			0.36	ς Ω	0.44		0.44		
		$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V			<b>3</b> 1.65			1.65	]		
Ц	Control inputs	$V_I = V_{CC}$ or GND	5.5 V			±0.1	50	±1		±1	μA	
I <sub>OZ</sub>	A or B ports	$V_{O} = V_{CC}$ or GND	5.5 V			±0.5		±5		±5	μA	
ICC		$V_{I} = V_{CC} \text{ or GND}, \qquad I_{O} = 0$	5.5 V			8		80		80	μA	
$\Delta I_{CC}^{\ddagger}$		One input at 3.4 V, Other inputs at V <sub>CC</sub> or GND	5.5 V			0.9		1		1	mA	
Ci	Control inputs	$V_{I} = V_{CC}$ or GND	5 V		4.5						pF	
Cio	A or B ports	V <sub>O</sub> = V <sub>CC</sub> or GND	5 V		16						pF	

<sup>†</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

 $\ddagger$  For I/O ports, the parameter IOZ includes the input leakage current.

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	FROM TO	T <sub>A</sub> = 25°C		54ACT16623		74ACT16623		LINUT	
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
<sup>t</sup> PLH	A or B	B or A	4.2	7.3	9.5	4.2	10.4	4.2	10.4	ns
<sup>t</sup> PHL	AUID	BUIA	3.1	7.3	9.5	3.1	10.3	3.1	10.3	115
<sup>t</sup> PZH	OEBA	A	2.7	6.8	8.8	2.7	9.5	2.7	9.5	ns
<sup>t</sup> PZL			3.5	8.2	10.2	3.5	x11.1	3.5	11.1	115
<sup>t</sup> PHZ	OEBA	А	6	9.6	11.3	6	12	6	12	ns
<sup>t</sup> PLZ	UEBA	~	5.3	8.6	10.3	5.3	10.7	5.3	10.7	115
<sup>t</sup> PZH	OEAB	В	4.1	6.9	8.7	4.1	9.3	4.1	9.3	ns
<sup>t</sup> PZL	UEAD	В	5.1	7.9	9.7	<b>Q</b> 5.1	10.6	5.1	10.6	115
<sup>t</sup> PHZ	OEAB B	В	5.1	8.2	10.2	5.1	10.4	5.1	10.4	ns
<sup>t</sup> PLZ		6	4.4	7.4	9.3	4.4	9.5	4.4	9.5	115

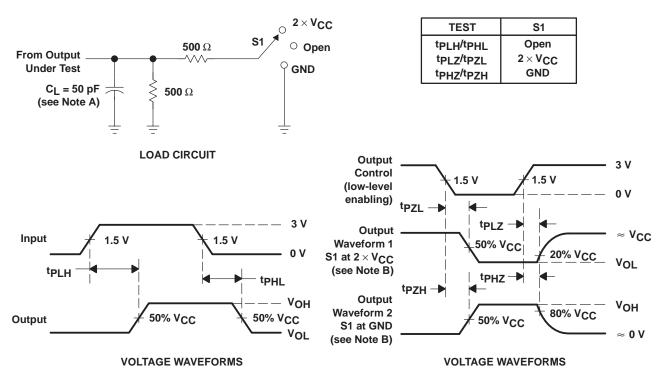
## operating characteristics, $V_{CC}$ = 5 V, $T_A$ = 25°C

PARAMETER			TEST C	TYP	UNIT
C <sub>pd</sub> Power dissipation capacitance per transceiver	Outputs enabled	C: 50 pF	6 1 MILI-	56	<b>л</b> Г
	Power dissipation capacitance per transceiver	Outputs disabled	C <sub>L</sub> = 50 pF,	f = 1 MHz	11

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#### PARAMETER MEASUREMENT INFORMATION

- NOTES: A. CL includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>Q</sub> = 50  $\Omega$ , t<sub>f</sub> = 3 ns, t<sub>f</sub> = 3 ns.
  - D. The outputs are measured one at a time with one input transition per measurement.

#### Figure 1. Load Circuit and Voltage Waveforms



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